

11C70



Not Intended For New Designs

T-46-07-08

# 11C70 Master-Slave D-Type Flip-Flop

## General Description

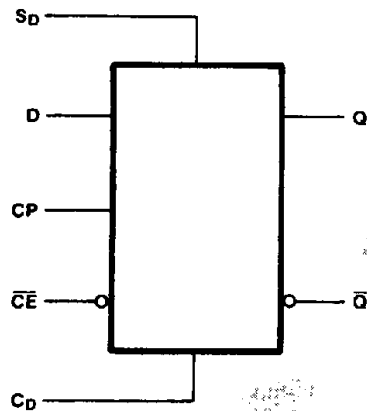
The 11C70 is a high-speed ECL D-Type Master-Slave Flip-Flop capable of toggle rates over 650 MHz. Designed primarily for communications and instrumentation, it can also be used in other digital applications and is fully compatible with 10K ECL. Asynchronous Direct Set and Direct Clear inputs are provided which override the clock.

The circuit is voltage-compensated, which makes output levels and input thresholds insensitive to  $V_{EE}$  variations.

This also allows operation with ECL supply voltage  $V_{EE}$  of  $-5.2V$  or with TTL supply  $V_{CC}$  of  $+5.0V$ . Each input has an internal  $50\text{ k}\Omega$  pull-down resistor, which allows unused inputs to be left open. Open emitter-follower outputs accommodate a variety of loading and terminating schemes. The 11C70 is pin-compatible with the Motorola MC1670 but is a higher-frequency replacement.

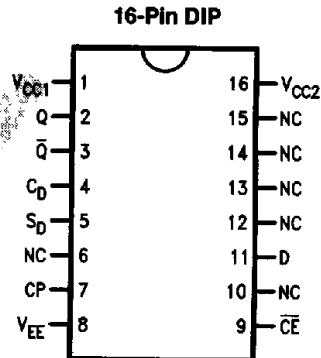
**Ordering Code:** See Section 6

## Logic Symbol



TL/F/9891-2

## Connection Diagram



TL/F/9891-1

Pin Names	Description
$\overline{CE}$	Clock Enable (Active LOW)
CP	Clock Pulse
D	Data Input
Q, $\overline{Q}$	Outputs
$S_D$	Direct Set
$C_D$	Direct Clear

## Truth Table

Inputs					$Q_{t+1}$	Operation
$S_D$	$C_D$	D	$\overline{CE}$	CP		
H	L	X	X	X	H	Direct Set
L	H	X	X	X	L	Direct Clear
H	H	X	X	X	—	Intermediate
L	L	X	H	↗	$Q_t$	Disable Clock
L	L	H	L	↗	H	Clocked Set
L	L	L	L	↗	L	Clocked Clear

H = HIGH Voltage Level

L = LOW Voltage Level

X = Don't Care

↗ = LOW to HIGH Transition

$t, t+1$  = Time Before and After Clock Positive Transition

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### Absolute Maximum Ratings

Above which the useful life may be impaired  
 If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Storage Temperature	-65°C to +150°C
Maximum Junction Temperature (T <sub>J</sub> )	+150°C
Supply Voltage Range	-7.0V to GND
Input Voltage (DC)	V <sub>EE</sub> to GND
Output Current (DC Output HIGH)	-50 mA
Operating Range	-5.7V to -4.7V
Lead Temperature (Soldering, 10 sec.)	300°C

### Recommended Operating Conditions

	Min	Typ	Max
Supply Voltage (V <sub>EE</sub> )	-5.7V	-5.2V	-4.7V
Ambient Temperature (T <sub>A</sub> )	0°C		+75°C

### DC Electrical Characteristics

V<sub>EE</sub> = -5.2V, V<sub>CC</sub> = GND

Symbol	Parameter	Min	Typ	Max	Units	T <sub>A</sub>	Conditions
V <sub>OH</sub>	Output Voltage HIGH	-1000		-840	mV	0°C	V <sub>IN</sub> = V <sub>IHA</sub> or V <sub>ILB</sub> per Truth Table Loading 50Ω to -2V
		-960		-810	mV	+25°C	
		-900		-720	mV	+75°C	
V <sub>OL</sub>	Output Voltage LOW	-1870		-1665	mV	0°C	
		-1850		-1620	mV	+25°C	
		-1850		-1595	mV	+75°C	
V <sub>OHC</sub>	Output Voltage HIGH	-1020			mV	0°C	V <sub>IN</sub> = V <sub>IHB</sub> or V <sub>ILA</sub> for D Input Loading 50Ω to -2V
		-980			mV	+25°C	
		-920			mV	+75°C	
V <sub>OLC</sub>	Output Voltage LOW			-1615	mV	0°C	
				-1600	mV	+25°C	
				-1575	mV	+75°C	
V <sub>IH</sub>	Input Voltage HIGH	-1135		-840	mV	0°C	Guaranteed Input Voltage HIGH for All Inputs
		-1095		-810	mV	+25°C	
		-1035		-720	mV	+75°C	
V <sub>IL</sub>	Input Voltage LOW	-1870		-1500	mV	0°C	Guaranteed Input Voltage LOW for All Inputs
		-1850		-1485	mV	+25°C	
		-1830		-1460	mV	+75°C	
I <sub>IH</sub>	Input Current HIGH Clock Input Data Input S <sub>D</sub> and C <sub>D</sub>			250	μA	+25°C	V <sub>IN</sub> = V <sub>IHA</sub>
				270	μA		
				550	μA		
I <sub>IL</sub>	Input Current LOW	0.5			μA	+25°C	V <sub>IN</sub> = V <sub>IHB</sub>
I <sub>EE</sub>	Power Supply Current	-48			mA	+25°C	All Inputs Open

### AC Electrical Characteristics

V<sub>EE</sub> = -5.2V, V<sub>CC</sub> = GND, T<sub>A</sub> = +25°C

Symbol	Parameter	Min	Typ	Max	Units	Conditions
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay (CP-Q)		1.1	1.4	ns	See Figures 3 and 4
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay (S <sub>D</sub> -Q, C <sub>D</sub> -Q)		1.3	1.7	ns	
t <sub>TLH</sub>	Transition Time 20% to 80%		0.9	1.3	ns	
t <sub>THL</sub>	Transition Time 80% to 20%		0.9	1.3	ns	
f <sub>TOG (MAX)</sub>	Toggle Frequency (CP)	550	650		MHz	See Figure 2

Note: This device is guaranteed for f<sub>TOG(max)</sub> ≥ 500 MHz over the 0°C to +75°C temperature range.

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### Functional Description

Master and slave clock thresholds are internally offset in opposite directions to avoid race conditions or simultaneous master-slave changes when the clock has slow rise or fall times. While the clock is LOW, the slave is in a HOLD condition and information present on the D input is gated into the master. When the clock goes HIGH, it locks the master into its present state, making it insensitive to the D input, causing the new information to appear on the outputs.

The CP and  $\overline{CE}$  inputs are logically identical, but physical constraints associated with the Dual In-Line package make the  $\overline{CE}$  input slower at the upper end of the toggle range. To prevent new data from entering the master on the next CP LOW cycle,  $\overline{CE}$  should be HIGH while CP is still HIGH.

A HIGH signal on  $S_D$  or  $C_D$  will override the clocked inputs and force Q or  $\overline{Q}$ , respectively, to go HIGH. If both  $C_D$  and  $S_D$  are HIGH, the two output voltages will be somewhere between the HIGH and LOW levels and thus, cannot be usefully defined.

When the input signals for the 11C70 come from other ECL circuits, either 11CXX series or 10K types, these circuits will automatically provide appropriate signal swings, provided, of course, that these circuits are operated within their ratings and that due consideration is given to terminations appropriate to the particular application, as discussed in the F100K ECL Design Guide (Section 5 of Databook).

For applications where the clock signal comes from a circuit type other than ECL (in high frequency prescaling, for example) it is generally necessary to use external components to shift the signal levels and center them about the 11C70 input threshold region. A typical biasing scheme is shown in Figure 1. Resistors R1 and R2 are chosen such that the

quiescent voltage at the CP input is  $-1.3V$  with respect to the  $V_{CC}$  terminal of the 11C70. Also indicated is the coupling from  $\overline{Q}$  back to the D input to make a simple toggle. The clock source should be designed to provide a signal swing in the range of 400 mV to 1200 mV, peak-to-peak, over the specified frequency and temperature range. To avoid saturating the input transistor and thus limiting the frequency capability, the positive peak of the clock should not be more positive than  $-0.4V$  with respect to  $V_{CC}$ .

The 11C70 outputs have no internal pull-down resistors. When driving a microstrip line terminated at the far end by a resistor returned to  $-2V$  (w.r.t.  $V_{CC}$ ), the quiescent  $I_{OH}$  current in the line performs the pull-down function when the output starts to go LOW. For series termination or for short unterminated lines, a  $270\Omega$  resistor to  $V_{EE}$  will provide adequate pull-down current. The outputs switch slightly faster when both outputs are equally loaded than if only one output is loaded. Equal and opposite changes in Q and  $\overline{Q}$  load currents tend to cancel the effects of the small inductance of the  $V_{CC}$  pin.

The test arrangements illustrate the use of split power supplies, with a  $2V$   $V_{CC}$  and  $-3.2V$   $V_{EE}$ . This is done as a matter of instrumentation convenience, since it allows the outputs to be connected via  $50\Omega$  cables directly to the sampling scope inputs, which have  $50\Omega$  internal terminations. By thus avoiding the use of probes, test correlation problems between supplier and user are minimized. In actual applications, only a single power supply is needed, and ground can be assigned to  $V_{CC}$ , as in ECL systems or to  $V_{EE}$  as in TTL systems. RF bypass capacitors are recommended in either case.

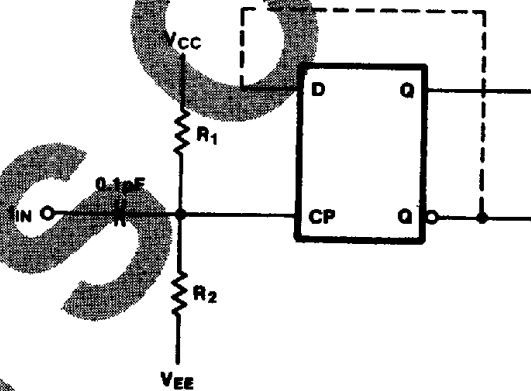
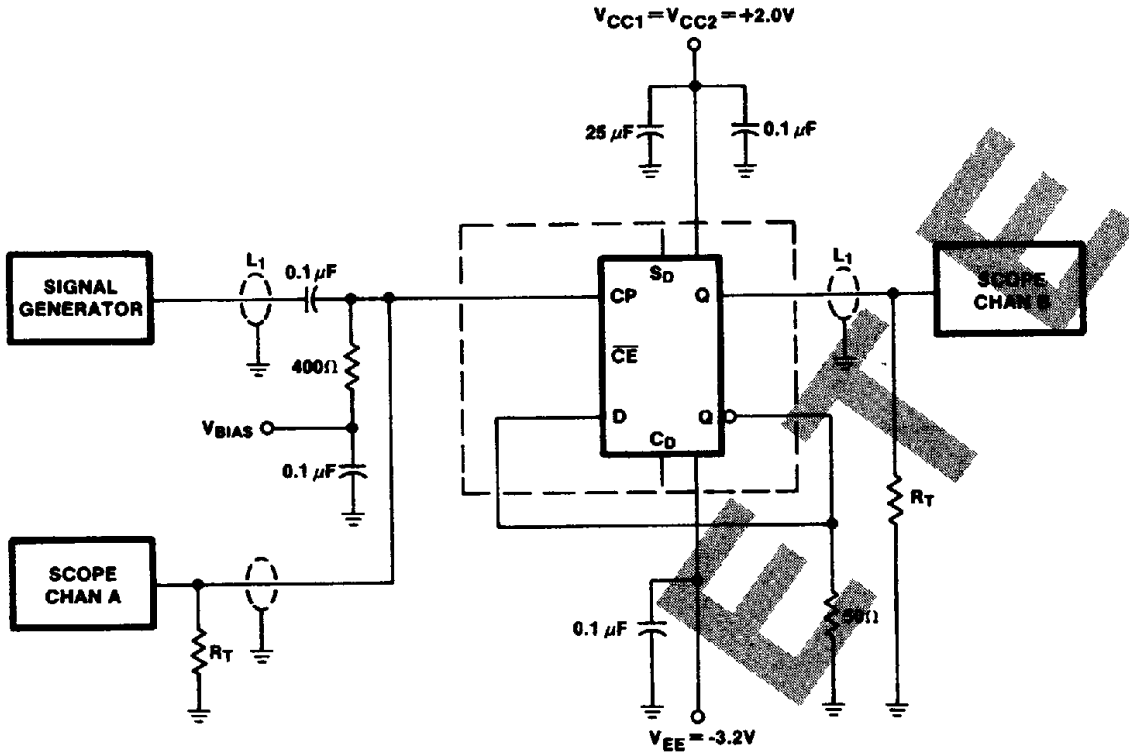


FIGURE 1. Input Biasing for AC Coupled Triggering

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$R_T = 50\Omega$  termination of scope  
 $L_1 = 50\Omega$  impedance lines  
 Adjust  $V_{BIAS}$  for  $\pm 0.7V$  baseline of  
 800 mV peak-to-peak sinewave input

TL/F/9891-4

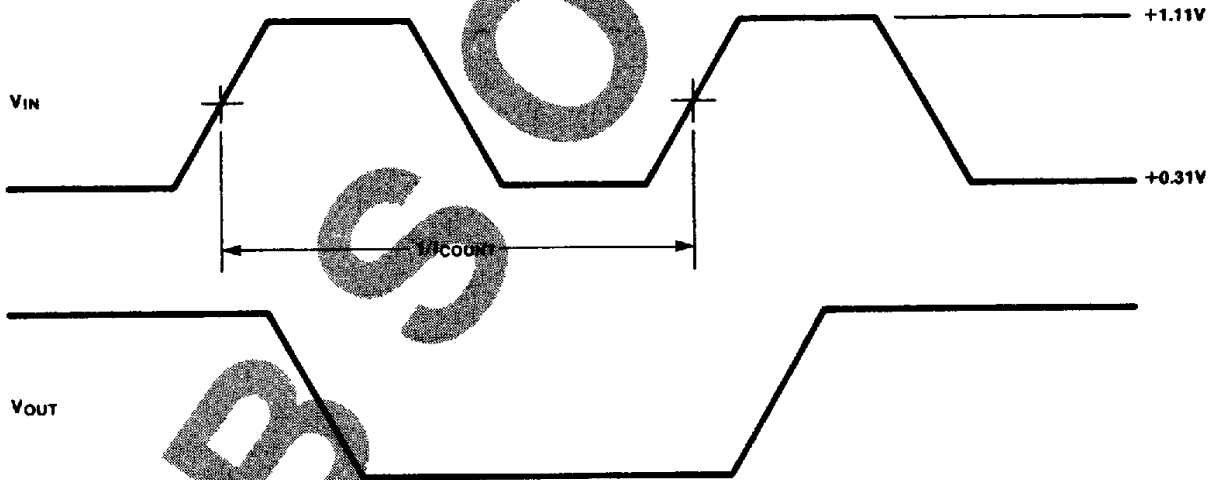
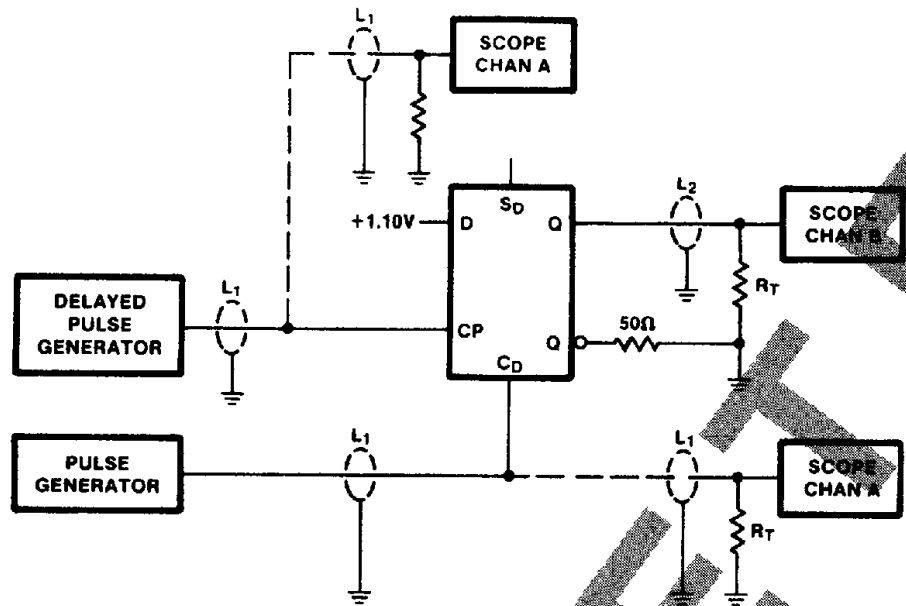


FIGURE 2. Toggle Frequency Test Circuit

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$V_{CC1} = V_{CC2} = +2.0V$   
 $V_{EE} = -3.2V$   
 $R_T = 50\Omega$  termination of scope  
 $L_1, L_2 =$  equal  $50\Omega$  impedance lines  
 All input transition times are  $2.0 \text{ ns} \pm 0.2 \text{ ns}$

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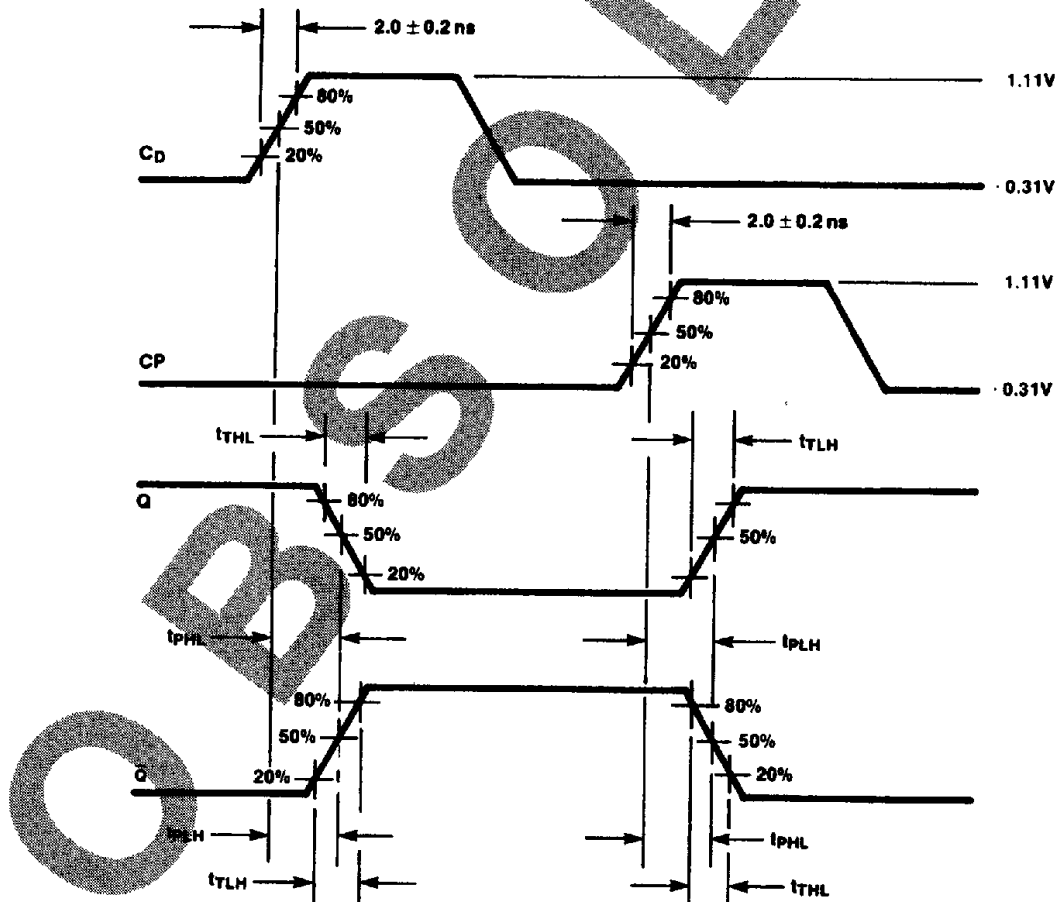
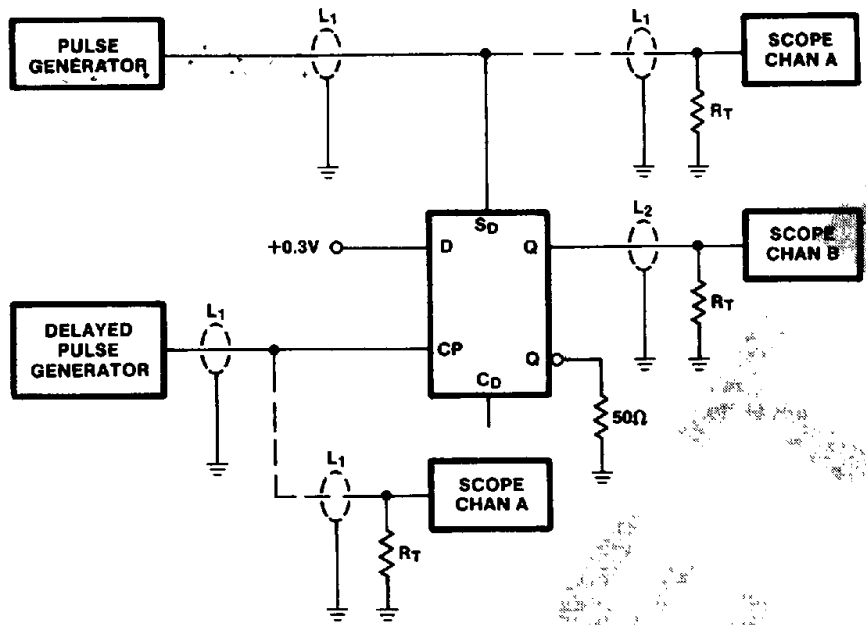


FIGURE 3. Propagation Delay and  $C_D$  Test Circuit

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$V_{CC1} = V_{CC2} = +2.0V$   
 $V_{EE} = -3.2V$   
 $R_T = 50\Omega$  termination of scope  
 $L_1, L_2 =$  equal  $50\Omega$  impedance lines  
 All input transition times are  $2.0\text{ ns} \pm 0.2\text{ ns}$

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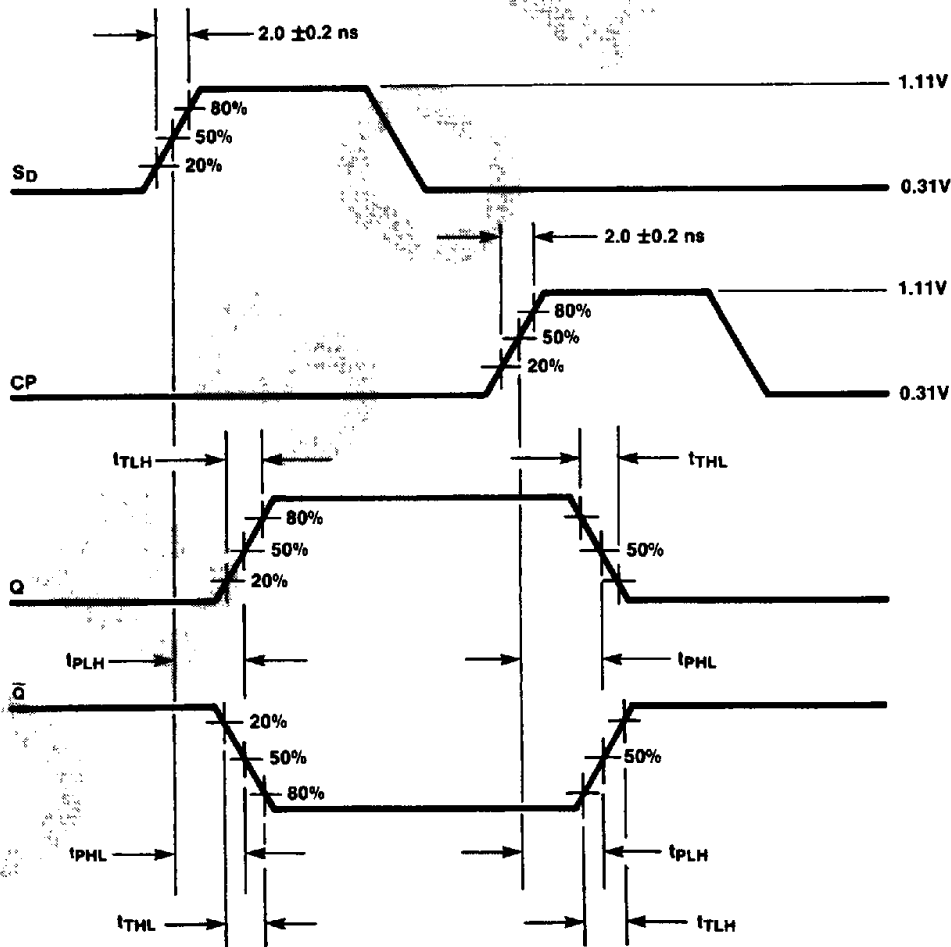


FIGURE 4. Propagation Delay and  $S_D$  Test Circuit

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